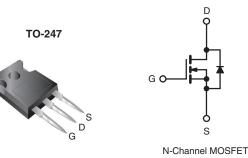


Power MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	500				
R _{DS(on)} (Ω)	V _{GS} = 10 V	0.27			
Q _g (Max.) (nC)	120				
Q _{gs} (nC)	32				
Q _{gd} (nC)	49				
Configuration	Single				



FEATURES

- Ultra Low Gate Charge
- Reduced Gate Drive Requirement
- Enhanced 30 V V_{GS} Rating
- Reduced Ciss, Coss, Crss
- Isolated Central Mounting Hole
- Dynamic dV/dt Rating
- · Repetitive Avalanche Rated
- · Lead (Pb)-free Available

DESCRIPTION

This new series of low charge Power MOSFETs achieve significantly lower gate charge over conventional MOSFETs. Utilizing advanced Power MOSFETs technology the device improvements allow for reduced gate drive requirements, faster switching speeds and increased total system savings. These device improvements combined with the proven ruggedness and reliability of Power MOSFETs offer the designer a new standard in power transistors for switching applications.

The TO-247 package is preferred for commercial-industrial applications where higher power levels preclude the use of TO-220 devices. The TO-247 is similar but superior to the earlier TO-218 package because its isolated mounting hole.

ORDERING INFORMATION	
Package	TO-247
Lead (Pb)-free	IRFP460LCPbF
	SiHFP460LC-E3
SnPb	IRFP460LC
	SiHFP460LC

ABSOLUTE MAXIMUM RATINGS $T_C = 25 ^{\circ}C$, unless otherwise noted						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	500	V	
Gate-Source Voltage			V _{GS}	± 30	v	
Continuous Drain Current	V_{GS} at 10 V	T _C = 25 °C	- I _D	20		
		T _C = 100 °C		12	A	
Pulsed Drain Current ^a			I _{DM}	80		
Linear Derating Factor				2.2	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	960	mJ	
Repetitive Avalanche Current ^a			I _{AR} 20		A	
Repetitive Avalanche Energy ^a			E _{AR}	28	mJ	
Maximum Power Dissipation	T _C =	25 °C	P _D 280		W	
Peak Diode Recovery dV/dt ^c			dV/dt	3.5	V/ns	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to + 150	°C		
Soldering Recommendations (Peak Temperature)	for 10 s		-	300 ^d	1	
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in	
				1.1	N · m	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. $V_{DD} = 25 \text{ V}$, starting $T_J = 25 \text{ °C}$, L = 4.3 mH, $R_G = 25 \Omega$, $I_{AS} = 20 \text{ A}$ (see fig. 12). c. $I_{SD} \le 20 \text{ A}$, dI/dt $\le 160 \text{ A/}\mu\text{s}$, $V_{DD} \le V_{DS}$, $T_J \le 150 \text{ °C}$.

d. 1.6 mm from case.

* Pb containing terminations are not RoHS compliant, exemptions may apply



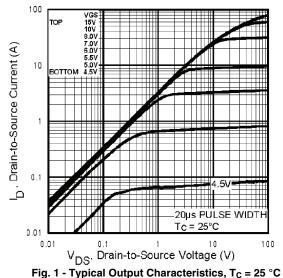


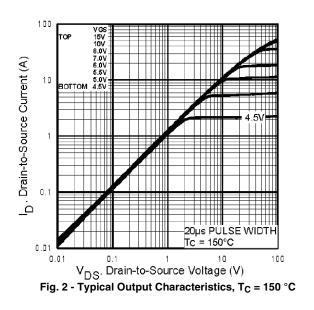
THERMAL RESISTANCE RA	TINGS							
PARAMETER	SYMBOL	TYP.		MAX.		UNIT		
Maximum Junction-to-Ambient	R _{thJA}	-		-				
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.24 -			°C/W			
Maximum Junction-to-Case (Drain)	R _{thJC}	-		0.45	1			
SPECIFICATIONS $T_J = 25 °C$,	unless other	wise noted						
PARAMETER	SYMBOL		CONDITIO	NS	MIN.	TYP.	MAX.	UNIT
Static					<u> </u>			
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0	0 V, I _D = 25	0 μΑ	500	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	to 25 °C, I _C) = 1 mA	-	0.59	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V$	/ _{GS} , I _D = 25	0 μΑ	2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}	Vo	$V_{GS} = \pm 20 \text{ V}$			-	± 100	nA
	V _{DS} = 500 V, V _{GS} = 0 V	= 0 V	-	-	25	μA		
Zero Gate Voltage Drain Current		Г _Ј = 125 °С	-	-	250			
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D	= 12 A ^b	-	-	0.27	Ω
Forward Transconductance	9 _{fs}	V _{DS} =	50 V, I _D = 1	2 A ^b	12	-	-	S
Dynamic								
Input Capacitance	C _{iss}	$V_{GS} = 0 V,$ $V_{DS} = 25 V,$		-	3600	-	pF	
Output Capacitance	C _{oss}			-	440	-		
Reverse Transfer Capacitance	C _{rss}	f = 1.0	f = 1.0 MHz, see fig. 5		-	39	-	1
Total Gate Charge	Qg			= 20 A, V _{DS} = 400 V, see fig. 6 and 13 ^b	-	-	120	nC
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V			-	-	32	
Gate-Drain Charge	Q _{gd}	1	see fig. 6 and 13°		-	-	49	
Turn-On Delay Time	t _{d(on)}				-	18	-	
Rise Time	t _r	- V_D = 2	250 V, I _D = 1	20 A	-	77	-	1
Turn-Off Delay Time	t _{d(off)}		$R_{G} = 4.3 \Omega, R_{D} = 12 \Omega, \text{ see fig. } 10^{b}$		-	40	-	ns
Fall Time	tf	1	-			43	-	1
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from		-	5.0	-	nH	
Internal Source Inductance	L _S	package and center of die contact			-	13		-
Drain-Source Body Diode Characteristic	cs					-	-	
Continuous Source-Drain Diode Current	١ _S	MOSFET symbol showing the		-	-	20	A	
Pulsed Diode Forward Current ^a	I _{SM}	integral reverse p - n junction diode			-	-		80
Body Diode Voltage	V _{SD}	$T_J = 25 \ ^\circ C, \ I_S = 20 \ A, \ V_{GS} = 0 \ V^b$			-	-	1.8	V
Body Diode Reverse Recovery Time	t _{rr}	- T _J = 25 °C, I _F = 20 A, dI/dt = 100 A/µs ^b		-	570	860	ns	
Body Diode Reverse Recovery Charge	Q _{rr}			-	6.6	9.9	μC	
Forward Turn-On Time	t _{on}	Intrinsic turr	n-on time is	negligible (turn	on is dor	minated b	$y L_S$ and	L _D)

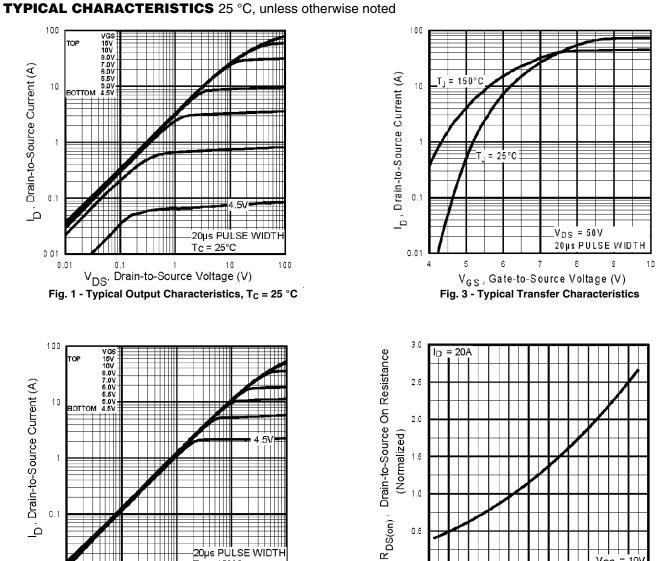
Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Pulse width \leq 300 μs ; duty cycle \leq 2 %.









1.5

1.0

0.5

0.0

-60 -40

-20 0



VGS

20 40 60 80 100 120 140 160

10\

IRFP460LC, SiHFP460LC

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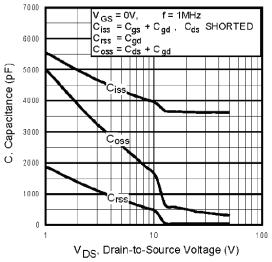


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

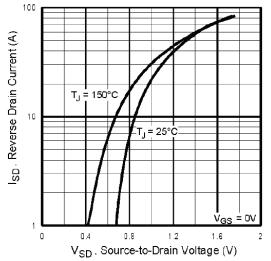


Fig. 7 - Typical Source-Drain Diode Forward Voltage

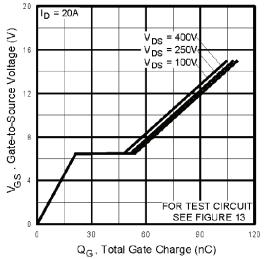


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

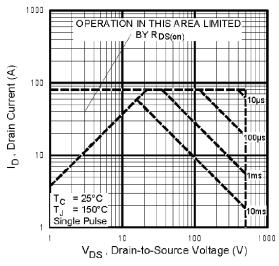


Fig. 8 - Maximum Safe Operating Area

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IRFP460LC, SiHFP460LC

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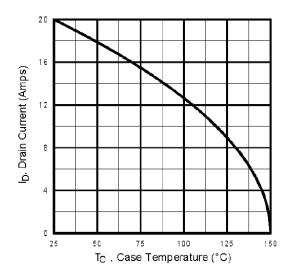


Fig. 9 - Maximum Drain Current vs. Case Temperature

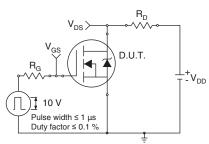


Fig. 10a - Switching Time Test Circuit

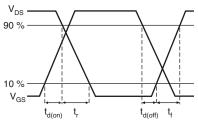


Fig. 10b - Switching Time Waveforms

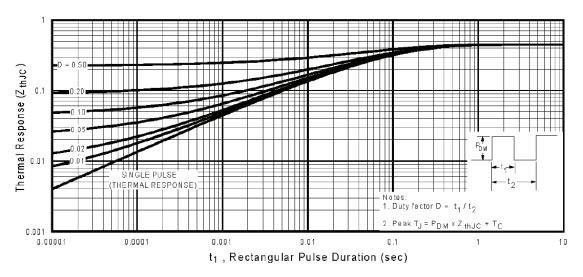


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

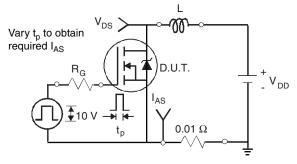


Fig. 12a - Unclamped Inductive Test Circuit

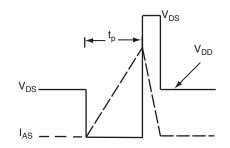


Fig. 12b - Unclamped Inductive Waveforms

IRFP460LC, SiHFP460LC

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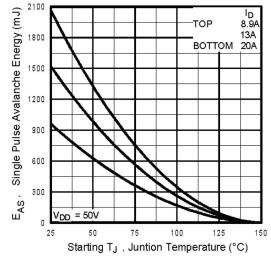


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

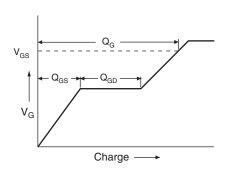


Fig. 13a - Basic Gate Charge Waveform

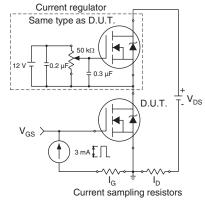
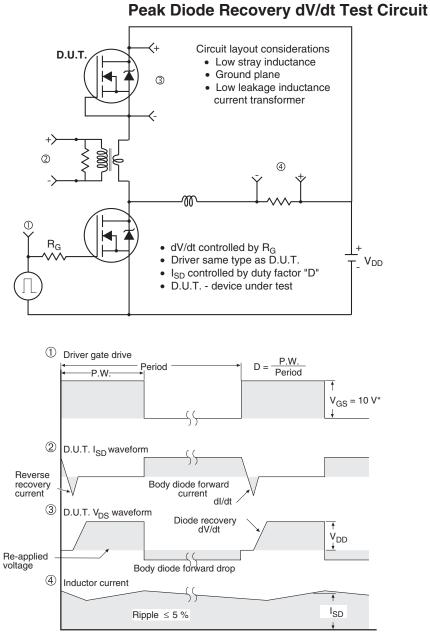


Fig. 13b - Gate Charge Test Circuit





* $V_{GS} = 5$ V for logic level devices

Fig. 14 - For N-Channel

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TO-247AC (High Voltage)

ECN: X13-0103-Rev. D, 01-Jul-13 DWG: 5971

Notes

1. Dimensioning and tolerancing per ASME Y14.5M-1994.

2. Contour of slot optional.

 Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm (0.005") per side. These dimensions are measured at the outermost extremes of the plastic body.

4. Thermal pad contour optional with dimensions D1 and E1.

5. Lead finish uncontrolled in L1.

6. Ø P to have a maximum draft angle of 1.5 to the top of the part with a maximum hole diameter of 3.91 mm (0.154").

7. Outline conforms to JEDEC outline TO-247 with exception of dimension c.

8. Xian and Mingxin actually photo.





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